# 74AUP1G175

Low-power D-type flip-flop with reset; positive-edge trigger

Rev. 3 — 30 September 2010 Product data sheet

## 1. General description

The 74AUP1G175 provides a low-power, low-voltage positive-edge triggered D-type flip-flop with individual data (D) input, clock (CP) input, master reset (MR) input, and Q output. The master reset (MR) is an asynchronous active LOW input and operates independently of the clock input. Information on the data input is transferred to the Q output on the LOW-to-HIGH transition of the clock pulse. The D input must be stable one set-up time prior to the LOW-to-HIGH clock transition, for predictable operation.

Schmitt trigger action at all inputs makes the circuit tolerant to slower input rise and fall times across the entire  $V_{CC}$  range from 0.8 V to 3.6 V. This device ensures a very low static and dynamic power consumption across the entire  $V_{CC}$  range from 0.8 V to 3.6 V.

This device is fully specified for partial power-down applications using I<sub>OFF</sub>. The I<sub>OFF</sub> circuitry disables the output, preventing the damaging backflow current through the device when it is powered down.

### 2. Features and benefits

- Wide supply voltage range from 0.8 V to 3.6 V
- High noise immunity
- Complies with JEDEC standards:
  - JESD8-12 (0.8 V to 1.3 V)
  - ◆ JESD8-11 (0.9 V to 1.65 V)
  - JESD8-7 (1.2 V to 1.95 V)
  - ◆ JESD8-5 (1.8 V to 2.7 V)
  - ◆ JESD8-B (2.7 V to 3.6 V)
- ESD protection:
  - HBM JESD22-A114F Class 3A exceeds 5000 V
  - ♦ MM JESD22-A115-A exceeds 200 V
  - CDM JESD22-C101E exceeds 1000 V
- Low static power consumption;  $I_{CC} = 0.9 \mu A$  (maximum)
- Latch-up performance exceeds 100 mA per JESD 78 Class II
- Inputs accept voltages up to 3.6 V
- Low noise overshoot and undershoot < 10 % of V<sub>CC</sub>
- I<sub>OFF</sub> circuitry provides partial Power-down mode operation
- Multiple package options
- Specified from -40 °C to +85 °C and -40 °C to +125 °C



# 3. Ordering information

Table 1. Ordering information

Type number	Package			
	Temperature range	Name	Description	Version
74AUP1G175GW	–40 °C to +125 °C	SC-88	plastic surface-mounted package; 6 leads	SOT363
74AUP1G175GM	–40 °C to +125 °C	XSON6	plastic extremely thin small outline package; no leads; 6 terminals; body 1 $\times$ 1.45 $\times$ 0.5 mm	SOT886
74AUP1G175GF	–40 °C to +125 °C	XSON6	plastic extremely thin small outline package; no leads; 6 terminals; body 1 $\times$ 1 $\times$ 0.5 mm	SOT891
74AUP1G175GN	–40 °C to +125 °C	XSON6	extremely thin small outline package; no leads; 6 terminals; body $0.9 \times 1.0 \times 0.35$ mm	SOT1115
74AUP1G175GS	–40 °C to +125 °C	XSON6	extremely thin small outline package; no leads; 6 terminals; body $1.0 \times 1.0 \times 0.35$ mm	SOT1202

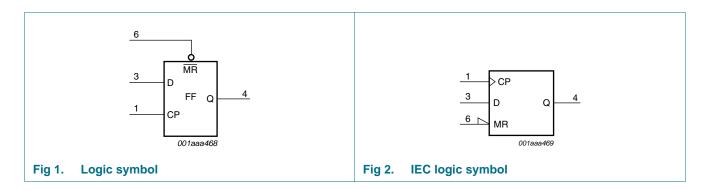
## 4. Marking

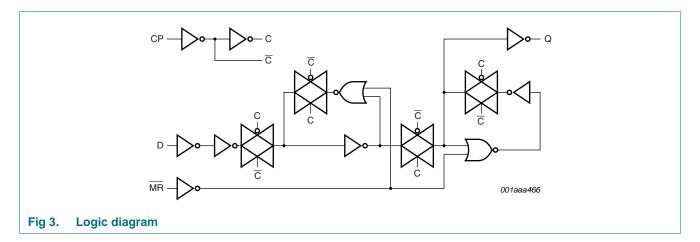
Table 2. Marking

Type number	Marking code <sup>[1]</sup>
74AUP1G175GW	аТ
74AUP1G175GM	аТ
74AUP1G175GF	аТ
74AUP1G175GN	аТ
74AUP1G175GS	аТ

<sup>[1]</sup> The pin 1 indicator is located on the lower left corner of the device, below the marking code.

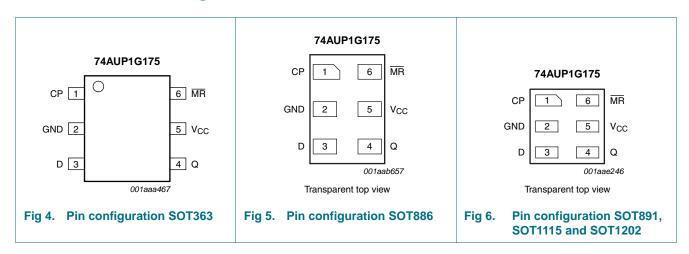
# 5. Functional diagram





# 6. Pinning information

## 6.1 Pinning



### 6.2 Pin description

Table 3. Pin description

Symbol	Pin	Description
СР	1	clock input (LOW-to-HIGH, edge-triggered)
GND	2	ground (0 V)
D	3	data input
Q	4	flip-flop output
V <sub>CC</sub>	5	supply voltage
MR	6	master reset input (active LOW)

## 7. Functional description

Table 4. Function table[1]

Operating mode	Input	nput					
	MR	MR CP D					
Reset (clear)	L	X	X	L			
Load '1'	Н	<b>↑</b>	h	Н			
Load '0'	Н	<b>↑</b>	I	L			

<sup>[1]</sup> H = HIGH voltage level;

h = HIGH voltage level one set-up time prior to the LOW-to-HIGH CP transition;

I = LOW voltage level one set-up time prior to the LOW-to-HIGH CP transition;

## 8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CC}$	supply voltage		-0.5	+4.6	V
I <sub>IK</sub>	input clamping current	V <sub>I</sub> < 0 V	<b>–</b> 50	-	mA
VI	input voltage		<u>[1]</u> –0.5	+4.6	V
I <sub>OK</sub>	output clamping current	V <sub>O</sub> < 0 V	<b>–</b> 50	-	mA
V <sub>O</sub>	output voltage	Active mode and Power-down mode	<u>[1]</u> –0.5	+4.6	V
Io	output current	$V_O = 0 V \text{ to } V_{CC}$	-	±20	mA
I <sub>CC</sub>	supply current		-	50	mA
I <sub>GND</sub>	ground current		<b>–</b> 50	-	mA
T <sub>stg</sub>	storage temperature		<b>–</b> 65	+150	°C
P <sub>tot</sub>	total power dissipation	$T_{amb} = -40  ^{\circ}\text{C} \text{ to } +125  ^{\circ}\text{C}$	[2] -	250	mW

<sup>[1]</sup> The minimum input and output voltage ratings may be exceeded if the input and output current ratings are observed.

L = LOW voltage level;

<sup>↑ =</sup> LOW-to-HIGH CP transition;

X = don't care.

<sup>[2]</sup> For SC-88 packages: above 87.5 °C the value of P<sub>tot</sub> derates linearly with 4.0 mW/K. For XSON6 packages: above 118 °C the value of P<sub>tot</sub> derates linearly with 7.8 mW/K.

# 9. Recommended operating conditions

Table 6. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CC}$	supply voltage		0.8	3.6	V
VI	input voltage		0	3.6	V
Vo	output voltage	Active mode	0	$V_{CC}$	V
		Power-down mode; V <sub>CC</sub> = 0 V	0	3.6	V
T <sub>amb</sub>	ambient temperature		-40	+125	°C
Δt/ΔV	input transition rise and fall rate	$V_{CC} = 0.8 \text{ V to } 3.6 \text{ V}$	-	200	ns/V

## 10. Static characteristics

Table 7. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
T <sub>amb</sub> = 2	5 °C					
V <sub>IH</sub>	HIGH-level input voltage	V <sub>CC</sub> = 0.8 V	$0.70 \times V_{CC}$	-	-	V
		V <sub>CC</sub> = 0.9 V to 1.95 V	$0.65 \times V_{CC}$	-	-	V
		V <sub>CC</sub> = 2.3 V to 2.7 V	1.6	-	-	V
		V <sub>CC</sub> = 3.0 V to 3.6 V	2.0	-	-	V
V <sub>IL</sub>	LOW-level input voltage	V <sub>CC</sub> = 0.8 V	-	-	$0.30 \times V_{CC}$	V
		V <sub>CC</sub> = 0.9 V to 1.95 V	-	-	$0.35 \times V_{CC}$	V
		V <sub>CC</sub> = 2.3 V to 2.7 V	-	-	0.7	V
		V <sub>CC</sub> = 3.0 V to 3.6 V	-	-	0.9	V
V <sub>OH</sub>	HIGH-level output voltage	$V_I = V_{IH}$ or $V_{IL}$				
		$I_O = -20 \ \mu A; \ V_{CC} = 0.8 \ V \ to \ 3.6 \ V$	$V_{CC} - 0.1$	-	-	V
		$I_{O} = -1.1 \text{ mA}; V_{CC} = 1.1 \text{ V}$	$0.75 \times V_{CC}$	-	-	V
		$I_{O} = -1.7 \text{ mA}; V_{CC} = 1.4 \text{ V}$	1.11	-	-	V
		$I_{O} = -1.9 \text{ mA}; V_{CC} = 1.65 \text{ V}$	1.32	-	-	V
		$I_{O} = -2.3 \text{ mA}; V_{CC} = 2.3 \text{ V}$	2.05	-	-	V
		$I_{O} = -3.1 \text{ mA}; V_{CC} = 2.3 \text{ V}$	1.9	-	-	V
		$I_{O} = -2.7 \text{ mA}; V_{CC} = 3.0 \text{ V}$	2.72	-	-	V
		$I_{O} = -4.0 \text{ mA}; V_{CC} = 3.0 \text{ V}$	2.6	-	-	V
V <sub>OL</sub>	LOW-level output voltage	$V_I = V_{IH}$ or $V_{IL}$				
		$I_O$ = 20 $\mu$ A; $V_{CC}$ = 0.8 V to 3.6 V	-	-	0.1	V
		$I_{O} = 1.1 \text{ mA}; V_{CC} = 1.1 \text{ V}$	-	0.65 × V <sub>CC</sub> V 0.66 V 1.00 V - 0.30 × V <sub>CC</sub> V - 0.35 × V <sub>CC</sub> V - 0.7 V - 0.9 V 0.75 × V <sub>CC</sub> V 1.11 V 1.32 V 1.05 V 1.72 V 1.72 V 1.72 V 1.72 V 1.72 V 1.72 V 1.72 V 1.72 V 1.73 × V <sub>CC</sub> V 1.74 V 1.75 × V <sub>CC</sub> V 1.77 V 1.77 V 1.77 V 1.78 V 1.79 V 1.70 V 1.71 V 1.72 V 1.72 V 1.72 V 1.74 V 1.75 × V <sub>CC</sub> V 1.77 - V	V	
		$I_{O} = 1.7 \text{ mA}; V_{CC} = 1.4 \text{ V}$	-	-	0.31	V
		I <sub>O</sub> = 1.9 mA; V <sub>CC</sub> = 1.65 V	-	-	0.31	V
		$I_{O} = 2.3 \text{ mA}; V_{CC} = 2.3 \text{ V}$	-	-	0.31	V
		$I_{O} = 3.1 \text{ mA}; V_{CC} = 2.3 \text{ V}$	-	-	0.44	V
		$I_{O} = 2.7 \text{ mA}; V_{CC} = 3.0 \text{ V}$	-	-	0.31	V
		$I_{O}$ = 4.0 mA; $V_{CC}$ = 3.0 V	-	-	0.44	V
4AUP1G175		All information provided in this document is subject to legal disclain	ners.		© NXP B.V. 2010. All righ	nts reserve

 Table 7.
 Static characteristics ...continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I <sub>I</sub>	input leakage current	$V_I = GND$ to 3.6 V; $V_{CC} = 0$ V to 3.6 V	-	-	±0.1	μΑ
l <sub>OFF</sub>	power-off leakage current	$V_I$ or $V_O = 0$ V to 3.6 V; $V_{CC} = 0$ V	-	-	±0.2	μΑ
$\Delta I_{OFF}$	additional power-off leakage current	$V_1$ or $V_0 = 0$ V to 3.6 V; $V_{CC} = 0$ V to 0.2 V	-	-	±0.2	μΑ
cc	supply current	$V_I$ = GND or $V_{CC}$ ; $I_O$ = 0 A; $V_{CC}$ = 0.8 V to 3.6 V	-	-	0.5	μΑ
Δl <sub>CC</sub>	additional supply current	$V_I = V_{CC} - 0.6 \text{ V}; I_O = 0 \text{ A};$ $V_{CC} = 3.3 \text{ V}$	[1] -	-	40	μΑ
Cı	input capacitance	$V_{CC} = 0 \text{ V to } 3.6 \text{ V}; V_I = \text{GND or } V_{CC}$	-	8.0	-	pF
Co	output capacitance	$V_O = GND; V_{CC} = 0 V$	-	1.7	-	pF
T <sub>amb</sub> = -	40 °C to +85 °C					
V <sub>IH</sub>	HIGH-level input voltage	V <sub>CC</sub> = 0.8 V	$0.70 \times V_{CC}$	-	-	V
		V <sub>CC</sub> = 0.9 V to 1.95 V	$0.65 \times V_{CC}$	-	-	V
		$V_{CC}$ = 2.3 V to 2.7 V	1.6	-	-	V
		V <sub>CC</sub> = 3.0 V to 3.6 V	2.0	-	±0.1 ±0.2 ±0.2 0.5	V
V <sub>IL</sub>	LOW-level input voltage	V <sub>CC</sub> = 0.8 V	-	-	$0.30 \times V_{CC}$	V
		V <sub>CC</sub> = 0.9 V to 1.95 V	-	-	$0.35 \times V_{CC}$	V
		$V_{CC}$ = 2.3 V to 2.7 V	-	-	0.7	V
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	-	-	0.9	V
V <sub>OH</sub>	HIGH-level output voltage	$V_I = V_{IH}$ or $V_{IL}$				
		$I_{O} = -20 \mu A$ ; $V_{CC} = 0.8 \text{ V to } 3.6 \text{ V}$	V <sub>CC</sub> - 0.1	-	-	V
		$I_{O} = -1.1 \text{ mA}; V_{CC} = 1.1 \text{ V}$	$0.7 \times V_{CC}$	-	-	V
		$I_{O} = -1.7 \text{ mA}; V_{CC} = 1.4 \text{ V}$	1.03	-	-	V
		$I_{O} = -1.9 \text{ mA}; V_{CC} = 1.65 \text{ V}$	1.30	-	-	V
		$I_{O} = -2.3 \text{ mA}; V_{CC} = 2.3 \text{ V}$	1.97	-	-	V
		$I_{O} = -3.1 \text{ mA}; V_{CC} = 2.3 \text{ V}$	1.85	-	-	V
		$I_{O} = -2.7 \text{ mA}; V_{CC} = 3.0 \text{ V}$	2.67	-	-	V
		$I_{O} = -4.0 \text{ mA}; V_{CC} = 3.0 \text{ V}$	2.55	-	-	V
V <sub>OL</sub>	LOW-level output voltage	$V_I = V_{IH}$ or $V_{IL}$				
		$I_O = 20 \mu A$ ; $V_{CC} = 0.8 \text{ V to } 3.6 \text{ V}$	-	-	0.1	V
		I <sub>O</sub> = 1.1 mA; V <sub>CC</sub> = 1.1 V	-	-	40  3	V
		$I_{O} = 1.7 \text{ mA}; V_{CC} = 1.4 \text{ V}$	-	-	0.37	V
		$I_O = 1.9 \text{ mA}; V_{CC} = 1.65 \text{ V}$	-	-	0.35	V
		$I_O = 2.3 \text{ mA}; V_{CC} = 2.3 \text{ V}$	-	-	0.33	V
		$I_{O} = 3.1 \text{ mA}; V_{CC} = 2.3 \text{ V}$	-	-	0.45	V
		$I_{O} = 2.7 \text{ mA}; V_{CC} = 3.0 \text{ V}$	-	-	0.33	V
		$I_{O} = 4.0 \text{ mA}; V_{CC} = 3.0 \text{ V}$	-	-	0.45	V
lį	input leakage current	$V_I = GND$ to 3.6 V; $V_{CC} = 0$ V to 3.6 V	-	-	±0.5	μΑ
l <sub>OFF</sub>	power-off leakage current	$V_I$ or $V_O = 0$ V to 3.6 V; $V_{CC} = 0$ V	-	-	±0.5	μΑ
$\Delta I_{OFF}$	additional power-off leakage current	$V_1$ or $V_0 = 0$ V to 3.6 V; $V_{CC} = 0$ V to 0.2 V	-	-	±0.6	μΑ

 Table 7.
 Static characteristics ...continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
I <sub>CC</sub>	supply current	$V_I$ = GND or $V_{CC}$ ; $I_O$ = 0 A; $V_{CC}$ = 0.8 V to 3.6 V		-	-	0.9	μΑ
$\Delta I_{CC}$	additional supply current	$V_{I} = V_{CC} - 0.6 \text{ V}; I_{O} = 0 \text{ A};$ $V_{CC} = 3.3 \text{ V}$	<u>[1]</u>	-	-	50	μΑ
T <sub>amb</sub> = -	40 °C to +125 °C						
$V_{IH}$	HIGH-level input voltage	V <sub>CC</sub> = 0.8 V		$0.75 \times V_{CC}$	-	-	V
		V <sub>CC</sub> = 0.9 V to 1.95 V		$0.70 \times V_{CC}$	-	-	V
		V <sub>CC</sub> = 2.3 V to 2.7 V		1.6	-	-	V
		V <sub>CC</sub> = 3.0 V to 3.6 V		2.0	-	-	V
$V_{IL}$	LOW-level input voltage	V <sub>CC</sub> = 0.8 V		-	-	$0.25 \times V_{CC}$	V
		V <sub>CC</sub> = 0.9 V to 1.95 V		-	-	$0.30 \times V_{CC}$	V
		V <sub>CC</sub> = 2.3 V to 2.7 V		-	-	0.7	V
		V <sub>CC</sub> = 3.0 V to 3.6 V		-	-	0.9	V
V <sub>OH</sub>	HIGH-level output voltage	$V_I = V_{IH}$ or $V_{IL}$					
		$I_O = -20 \mu A$ ; $V_{CC} = 0.8 \text{ V}$ to 3.6 V		V <sub>CC</sub> - 0.11	-	-	V
		$I_O = -1.1 \text{ mA}; V_{CC} = 1.1 \text{ V}$		$0.6 \times V_{CC}$	-	-	V
		$I_O = -1.7 \text{ mA}$ ; $V_{CC} = 1.4 \text{ V}$		0.93	-	-	V
		$I_O = -1.9 \text{ mA}$ ; $V_{CC} = 1.65 \text{ V}$ 1.17	-	V			
		$I_{O} = -2.3 \text{ mA}; V_{CC} = 2.3 \text{ V}$		1.77	-	-	V
		$I_O = -3.1 \text{ mA}; V_{CC} = 2.3 \text{ V}$		1.67	-	-	V
		$I_{O} = -2.7 \text{ mA}; V_{CC} = 3.0 \text{ V}$		2.40	-	-	V
		$I_O = -4.0 \text{ mA}; V_{CC} = 3.0 \text{ V}$		2.30	-	-	V
$V_{OL}$	LOW-level output voltage	$V_I = V_{IH}$ or $V_{IL}$					
		$I_O = 20 \mu A$ ; $V_{CC} = 0.8 \text{ V to } 3.6 \text{ V}$		-	-	0.11	V
		I <sub>O</sub> = 1.1 mA; V <sub>CC</sub> = 1.1 V		-	-	50  0.25 × V <sub>CC</sub> 0.30 × V <sub>CC</sub> 0.7 0.9	V
		$I_O = 1.7 \text{ mA}; V_{CC} = 1.4 \text{ V}$		-	-	0.41	V
		$I_O = 1.9 \text{ mA}; V_{CC} = 1.65 \text{ V}$		-	-	0.39	V
		$I_O = 2.3 \text{ mA}; V_{CC} = 2.3 \text{ V}$		-	-	0.36	V
		$I_O = 3.1 \text{ mA}; V_{CC} = 2.3 \text{ V}$		-	-	0.50	V
		$I_O = 2.7 \text{ mA}; V_{CC} = 3.0 \text{ V}$		-	-	0.36	V
		$I_O = 4.0 \text{ mA}; V_{CC} = 3.0 \text{ V}$		-	-	0.50	V
I <sub>I</sub>	input leakage current	$V_I = GND$ to 3.6 V; $V_{CC} = 0$ V to 3.6 V		-	-	±0.75	μΑ
I <sub>OFF</sub>	power-off leakage current	$V_I$ or $V_O = 0$ V to 3.6 V; $V_{CC} = 0$ V		-	-	±0.75	μΑ
$\Delta I_{OFF}$	additional power-off leakage current	$V_1$ or $V_0 = 0$ V to 3.6 V; $V_{CC} = 0$ V to 0.2 V		-	-	±0.75	μΑ
I <sub>CC</sub>	supply current	$V_I$ = GND or $V_{CC}$ ; $I_O$ = 0 A; $V_{CC}$ = 0.8 V to 3.6 V		-	-	1.4	μΑ
$\Delta I_{CC}$	additional supply current	$V_1 = V_{CC} - 0.6 \text{ V}; I_O = 0 \text{ A};$ $V_{CC} = 3.3 \text{ V}$	[1]	-	-	75	μΑ

<sup>[1]</sup> One input at  $V_{CC}$  – 0.6 V, other input at  $V_{CC}$  or GND.

# 11. Dynamic characteristics

Table 8. Dynamic characteristics

Voltages are referenced to GND (ground = 0 V); for test circuit see Figure 9.

Symbol	Parameter	Conditions		25 °C		-4	0 °C to +1	125 °C	Unit
			Min	Typ[1]	Max	Min	Max (85 °C)	Max (125 °C)	
$C_L = 5 pl$	F								
$t_{pd}$	propagation delay	CP to Q; see Figure 7	l						
		$V_{CC} = 0.8 V$	-	21.1	-	-	-	-	ns
		$V_{CC}$ = 1.1 V to 1.3 V	2.4	5.9	11.7	2.2	11.9	12.0	ns
		$V_{CC}$ = 1.4 V to 1.6 V	2.0	4.1	6.8	1.8	7.3	7.6	ns
		$V_{CC}$ = 1.65 V to 1.95 V	1.6	3.3	5.4	1.3	5.9	6.2	ns
		$V_{CC}$ = 2.3 V to 2.7 V	1.3	2.5	3.6	1.1	4.0	4.2	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	1.2	2.1	2.9	1.0	3.3	3.5	ns
		MR to Q; see Figure 8							
		$V_{CC} = 0.8 V$	-	17.4	-	-	-	-	ns
		$V_{CC} = 1.1 \text{ V to } 1.3 \text{ V}$	2.4	5.2	9.7	2.2	10.0	12.0	ns
		$V_{CC} = 1.4 \text{ V to } 1.6 \text{ V}$	2.3	3.8	5.2	2.1	6.4	6.6	ns
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$	1.8	3.1	4.9	1.7	5.4	5.6	ns
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	1.8	2.6	3.6	1.5	4.0	4.0	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	1.6	2.4	3.1	1.3	3.3	3.6	ns
f <sub>max</sub>	maximum	CP; see Figure 7							
	frequency	$V_{CC} = 0.8 \text{ V}$	-	50	-	-	-	-	MHz
		$V_{CC} = 1.1 \text{ V to } 1.3 \text{ V}$	-	200	-	170	-	-	MHz
		$V_{CC} = 1.4 \text{ V to } 1.6 \text{ V}$	-	345	-	310	-	-	MHz
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$	-	435	-	400	-	-	MHz
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	-	550	-	490	-	-	MHz
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	-	615	-	550	-	-	MHz

**Table 8. Dynamic characteristics** ...continued Voltages are referenced to GND (ground = 0 V); for test circuit see <u>Figure 9</u>.

Symbol	Parameter	Conditions		25 °C		-4	0 °C to +1	25 °C	Unit
			Min	Typ[1]	Max	Min	Max (85 °C)	Max (125 °C)	
C <sub>L</sub> = 10 p	ρF		'		'		'		'
t <sub>pd</sub>	propagation delay	CP to Q; see Figure 7							
		$V_{CC} = 0.8 \text{ V}$	-	24.7	-	-	-	-	ns
		$V_{CC} = 1.1 \text{ V to } 1.3 \text{ V}$	2.6	6.8	13.3	2.4	13.6	13.6	ns
		$V_{CC} = 1.4 \text{ V to } 1.6 \text{ V}$	2.3	4.8	7.9	2.0	8.4	8.7	ns
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$	2.1	3.9	6.1	1.8	6.6	6.9	ns
		$V_{CC}$ = 2.3 V to 2.7 V	1.7	3.0	4.3	1.5	4.7	5.0	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	1.6	2.7	3.6	1.3	4.0	4.2	ns
		MR to Q; see Figure 8 [2]							
		V <sub>CC</sub> = 0.8 V	-	21.0	-	-	-	-	ns
		$V_{CC} = 1.1 \text{ V to } 1.3 \text{ V}$	2.6	6.2	11.5	2.6	11.7	13.6	ns
	$V_{CC} = 1.4 \text{ V to } 1.6 \text{ V}$	2.5	4.4	6.1	2.4	7.6	7.8	ns	
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$	2.5	3.7	5.7	2.2	6.3	6.3	ns
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	2.1	3.2	4.3	1.9	4.7	4.9	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	2.0	3.0	3.9	1.8	4.1	4.3	ns
f <sub>max</sub>	maximum	CP; see Figure 7							
	frequency	$V_{CC} = 0.8 \text{ V}$	-	50	-	-	-	-	MHz
		$V_{CC} = 1.1 \text{ V to } 1.3 \text{ V}$	-	190	-	150	-	-	MHz
		$V_{CC} = 1.4 \text{ V to } 1.6 \text{ V}$	-	320	-	280	-	-	MHz
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$	-	420	-	310	-	-	MHz
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	-	485	-	370	-	-	MHz
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	-	550	-	410	-	-	MHz
C <sub>L</sub> = 15 p	oF								
t <sub>pd</sub>	propagation delay	CP to Q; see Figure 7							
		$V_{CC} = 0.8 \text{ V}$	-	28.1	-	-	-	-	ns
		$V_{CC} = 1.1 \text{ V to } 1.3 \text{ V}$	3.0	7.6	14.8	2.8	15.2	15.4	ns
		$V_{CC} = 1.4 \text{ V to } 1.6 \text{ V}$	2.7	5.3	8.7	2.3	9.4	9.9	ns
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$	2.3	4.4	6.8	2.1	7.4	7.9	ns
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	2.1	3.5	5.0	1.9	5.3	5.6	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	2.0	3.1	4.3	1.7	4.7	4.9	ns
		MR to Q; see Figure 8 [2]							
		$V_{CC} = 0.8 \text{ V}$	-	24.6	-	-	-	-	ns
		$V_{CC} = 1.1 \text{ V to } 1.3 \text{ V}$	3.2	7.0	13.2	2.9	13.5	15.2	ns
		$V_{CC} = 1.4 \text{ V to } 1.6 \text{ V}$	3.1	5.0	6.8	2.6	8.6	9.1	ns
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$	2.5	4.3	6.5	2.5	7.2	7.4	ns
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	2.6	3.7	5.0	2.2	5.4	5.5	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	2.4	3.5	4.4	2.1	4.8	5.0	ns

 Table 8.
 Dynamic characteristics ...continued

Voltages are referenced to GND (ground = 0 V); for test circuit see Figure 9.

Symbol	Parameter	Conditions		25 °C		-4	0 °C to +1	25 °C	Unit
			Min	Typ[1]	Max	Min	Max (85 °C)	Max (125 °C)	
$f_{\text{max}}$	maximum	CP; see Figure 7							
	frequency	$V_{CC} = 0.8 \text{ V}$	-	50	-	-	-	-	MHz
		$V_{CC} = 1.1 \text{ V to } 1.3 \text{ V}$	-	180	-	120	-	-	MHz
		$V_{CC} = 1.4 \text{ V to } 1.6 \text{ V}$	-	300	-	190	-	-	MHz
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$	-	405	-	240	-	-	MHz
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	-	420	-	300	-	-	MHz
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	-	480	-	320	-	-	MHz
C <sub>L</sub> = 30	ρF								
t <sub>pd</sub>	propagation delay	CP to Q; see Figure 7	2]						
		$V_{CC} = 0.8 \text{ V}$	-	38.4	-	-	-	-	ns
		$V_{CC} = 1.1 \text{ V to } 1.3 \text{ V}$	3.6	9.8	19.5	3.4	20.6	21.0	ns
		$V_{CC} = 1.4 \text{ V to } 1.6 \text{ V}$	3.3	6.9	11.2	3.2	12.4	13.0	ns
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$	3.1	5.7	8.8	2.9	9.6	10.2	ns
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	3.0	4.6	6.4	2.6	6.9	7.3	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	2.8	4.2	5.7	2.5	6.5	6.9	ns
		MR to Q; see Figure 8	<u>?]</u>						
		$V_{CC} = 0.8 \text{ V}$	-	35.1	-	-	-	-	ns
		$V_{CC} = 1.1 \text{ V to } 1.3 \text{ V}$	3.9	9.3	18.0	3.7	18.6	19.8	ns
		$V_{CC} = 1.4 \text{ V to } 1.6 \text{ V}$	3.9	6.6	8.9	3.6	11.6	12.2	ns
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$	3.6	5.6	8.6	3.4	9.6	9.7	ns
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	3.5	4.8	6.4	2.9	7.2	7.2	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	3.3	4.6	5.7	3.1	6.4	6.9	ns
f <sub>max</sub>	maximum	CP; see Figure 7							
	frequency	$V_{CC} = 0.8 \text{ V}$	-	35	-	-	-	-	MHz
		$V_{CC} = 1.1 \text{ V to } 1.3 \text{ V}$	-	130	-	70	-	-	MHz
		$V_{CC} = 1.4 \text{ V to } 1.6 \text{ V}$	-	200	-	120	-	-	MHz
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$	-	240	-	150	-	-	MHz
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	-	275	-	190	-	-	MHz
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	-	300	-	200	-	-	MHz

 Table 8.
 Dynamic characteristics ...continued

Voltages are referenced to GND (ground = 0 V); for test circuit see Figure 9.

Symbol	Parameter	Conditions		25 °C		-40 °C to +125 °C			Unit
			Min	Typ[1]	Max	Min	Max (85 °C)	Max (125 °C)	
C <sub>L</sub> = 5 pF	F, 10 pF, 15 pF and	30 pF	'	'	•	•	•		'
t <sub>W</sub>	pulse width	CP; HIGH or LOW; see Figure 7							
		$V_{CC} = 0.8 \text{ V}$	-	5.25	-	-	-	-	ns
		$V_{CC} = 1.1 \text{ V to } 1.3 \text{ V}$	-	1.6	-	1.5	-	-	ns
		$V_{CC} = 1.4 \text{ V to } 1.6 \text{ V}$	-	1.0	-	0.9	-	-	ns
		$V_{CC}$ = 1.65 V to 1.95 V	-	0.75	-	0.7	-	-	ns
		$V_{CC}$ = 2.3 V to 2.7 V	-	0.6	-	0.4	-	-	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	-	0.55	-	0.4	-	-	ns
		MR; LOW; see Figure 8							
		$V_{CC} = 0.8 \text{ V}$	-	9.0	-	-	-	-	ns
		$V_{CC} = 1.1 \text{ V to } 1.3 \text{ V}$	-	3.0	-	4.9	-	-	ns
		$V_{CC} = 1.4 \text{ V to } 1.6 \text{ V}$	-	1.75	-	2.5	-	-	ns
		$V_{CC}$ = 1.65 V to 1.95 V	-	1.35	-	1.8	-	-	ns
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	-	0.9	-	1.1	-	-	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	-	0.8	-	8.0	-	-	ns
t <sub>rec</sub> r	recovery time	MR; see Figure 8							
		$V_{CC} = 0.8 \text{ V}$	-	-	-	-	-	-	ns
		$V_{CC} = 1.1 \text{ V to } 1.3 \text{ V}$	-	-1.1	-	-1.2	-	-	ns
		$V_{CC} = 1.4 \text{ V to } 1.6 \text{ V}$	-	-2.0	-	-0.8	-	-	ns
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$	-	-0.5	-	-0.7	-	-	ns
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	-	-0.9	-	-0.4	-	-	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	-	-1.0	-	-0.2	-	-	ns
t <sub>su(H)</sub>	set-up time HIGH	D to CP; see Figure 7							
		$V_{CC} = 0.8 \text{ V}$	-	-	-	-	-	-	ns
		$V_{CC} = 1.1 \text{ V to } 1.3 \text{ V}$	-	0.5	-	1.2	-	-	ns
		$V_{CC} = 1.4 \text{ V to } 1.6 \text{ V}$	-	0.4	-	0.8	-	-	ns
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$	-	0.3	-	0.6	-	-	ns
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	-	0.3	-	0.5	-	-	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	-	0.2	-	0.5	-	-	ns
t <sub>su(L)</sub>	set-up time LOW	D to CP; see Figure 7							
,		V <sub>CC</sub> = 0.8 V	-	-	-	-	-	-	ns
		V <sub>CC</sub> = 1.1 V to 1.3 V	-	0.8	-	1.7	-	-	ns
		$V_{CC} = 1.4 \text{ V to } 1.6 \text{ V}$	-	0.6	-	1.1	-	-	ns
		V <sub>CC</sub> = 1.65 V to 1.95 V	-	0.4	-	0.9	-	-	ns
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	-	0.4	-	0.9	-	-	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	-	0.5	-	0.9	-	-	ns

 Table 8.
 Dynamic characteristics ...continued

Voltages are referenced to GND (ground = 0 V); for test circuit see Figure 9.

Symbol	Parameter	Conditions		25 °C			–40 °C to +125 °C			Unit
				Min	Typ[1]	Max	Min	Max (85 °C)	Max (125 °C)	
t <sub>h</sub>	hold time	D to CP; see Figure 7	'			•	•		'	'
		V <sub>CC</sub> = 0.8 V		-	-	-	-	-	-	ns
		$V_{CC} = 1.1 \text{ V to } 1.3 \text{ V}$		-	-0.7	-	0.2	-	-	ns
		$V_{CC} = 1.4 \text{ V to } 1.6 \text{ V}$		-	-0.5	-	0	-	-	ns
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$		-	-0.5	-	0	-	-	ns
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		-	-0.3	-	0	-	-	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$		-	-0.4	-	0	-	-	ns
$C_{PD}$	power dissipation capacitance	$f_i = 1 \text{ MHz};$ $V_I = \text{GND to } V_{CC}$	<u>[3]</u>							
		$V_{CC} = 0.8 \text{ V}$		-	1.6	-	-	-	-	pF
		$V_{CC} = 1.1 \text{ V to } 1.3 \text{ V}$		-	1.7	-	-	-	-	pF
		$V_{CC} = 1.4 \text{ V to } 1.6 \text{ V}$		-	1.8	-	-	-	-	pF
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$		-	1.9	-	-	-	-	pF
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		-	2.2	-	-	-	-	pF
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$		-	2.7	-	-	-	-	pF

<sup>[1]</sup> All typical values are measured at nominal  $V_{CC}$ .

$$P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \Sigma (C_L \times V_{CC}^2 \times f_o) \text{ where:}$$

 $f_i$  = input frequency in MHz;

f<sub>o</sub> = output frequency in MHz;

C<sub>L</sub> = output load capacitance in pF;

 $V_{CC}$  = supply voltage in V;

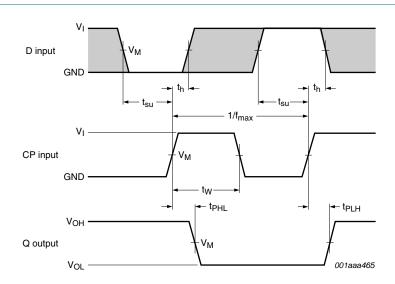
N = number of inputs switching;

 $\Sigma(C_L \times V_{CC}{}^2 \times f_o)$  = sum of the outputs.

<sup>[2]</sup>  $t_{pd}$  is the same as  $t_{PLH}$  and  $t_{PHL}$ .

<sup>[3]</sup>  $C_{PD}$  is used to determine the dynamic power dissipation ( $P_D$  in  $\mu W$ ).

### 12. Waveforms

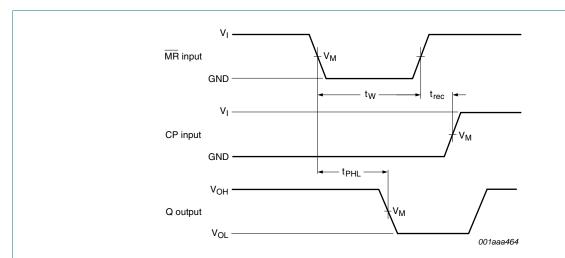


Measurement points are given in Table 9.

The shaded areas indicate when the input is permitted to change for predictable output performance.

V<sub>OL</sub> and V<sub>OH</sub> are typical output voltage drop that occur with the output load.

Fig 7. The clock input (CP) to output (Q) propagation delays, the clock pulse width, the D to CP set-up, the CP to D hold times and the maximum input clock frequency



Measurement points are given in Table 9.

 $V_{\mbox{\scriptsize OL}}$  and  $V_{\mbox{\scriptsize OH}}$  are typical output voltage drop that occur with the output load.

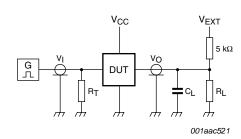
Fig 8. The master reset (MR) input to output (Q) propagation delays, the master reset pulse width and the MR to CP recovery time

Table 9. Measurement points

Supply voltage	Output	Input				
V <sub>CC</sub>	V <sub>M</sub>	V <sub>M</sub>	V <sub>I</sub>	$t_r = t_f$		
0.8 V to 3.6 V	$0.5 \times V_{CC}$	$0.5 \times V_{CC}$	V <sub>CC</sub>	≤ 3.0 ns		

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Test data is given in Table 10.

Definitions for test circuit:

 $R_L$  = Load resistance.

 $C_L$  = Load capacitance including jig and probe capacitance.

 $R_T$  = Termination resistance should be equal to the output impedance  $Z_0$  of the pulse generator.

 $V_{EXT}$  = External voltage for measuring switching times.

Fig 9. Test circuit for measuring switching times

#### Table 10. Test data

Supply voltage	Load		V <sub>EXT</sub>		
V <sub>CC</sub>	C <sub>L</sub>	R <sub>L</sub> [1]	t <sub>PLH</sub> , t <sub>PHL</sub>	t <sub>PZH</sub> , t <sub>PHZ</sub>	t <sub>PZL</sub> , t <sub>PLZ</sub>
0.8 V to 3.6 V	5 pF, 10 pF, 15 pF and 30 pF	5 k $\Omega$ or 1 M $\Omega$	open	GND	$2\times V_{CC}$

[1] For measuring enable and disable times  $R_L$  = 5  $k\Omega$ , for measuring propagation delays, setup and hold times and pulse width  $R_L$  = 1  $M\Omega$ .

## 13. Package outline

#### Plastic surface-mounted package; 6 leads

**SOT363** 

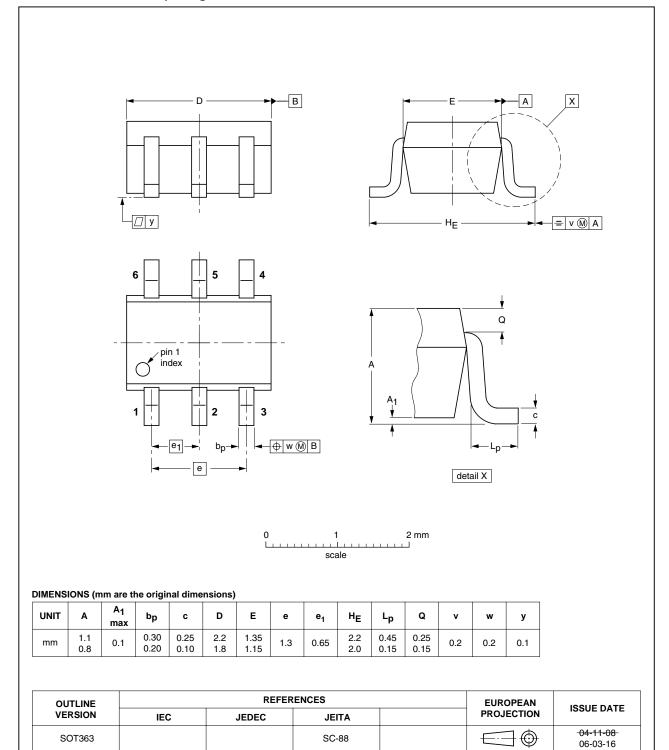


Fig 10. Package outline SOT363 (SC-88)

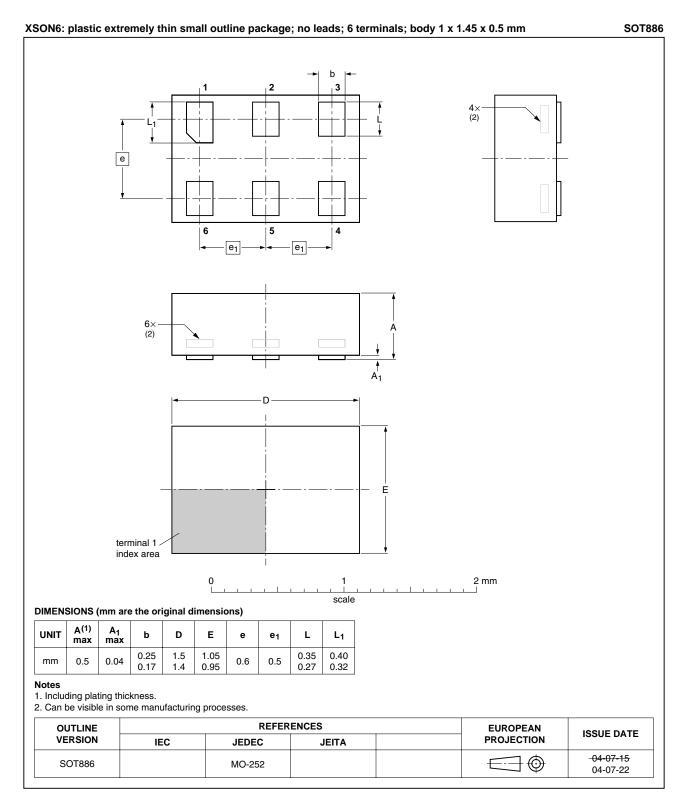


Fig 11. Package outline SOT886 (XSON6)

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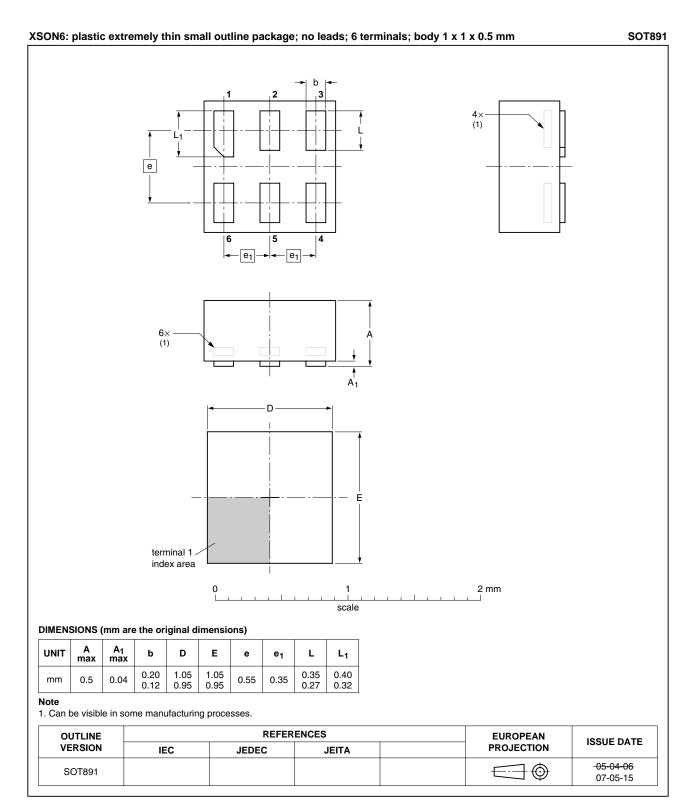


Fig 12. Package outline SOT891 (XSON6)

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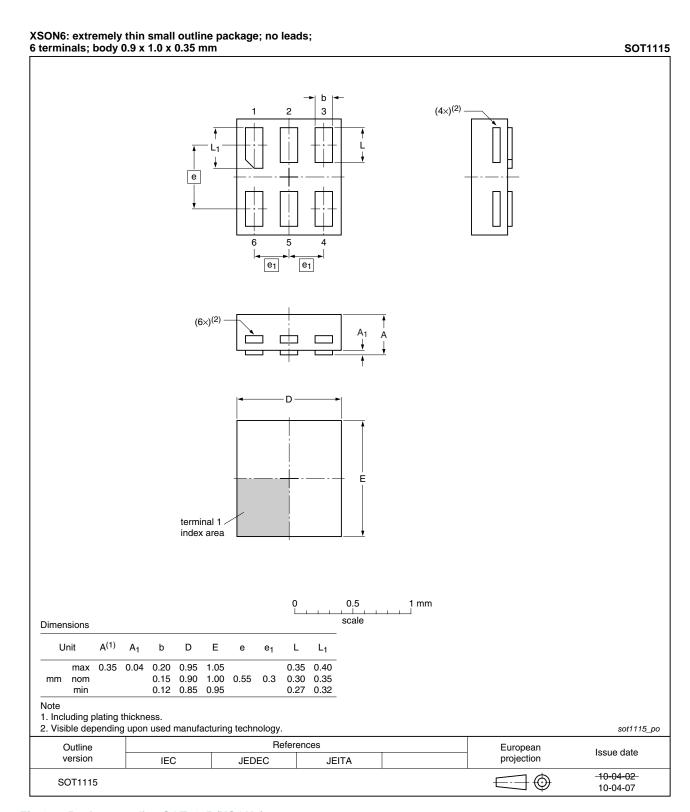


Fig 13. Package outline SOT1115 (XSON6)

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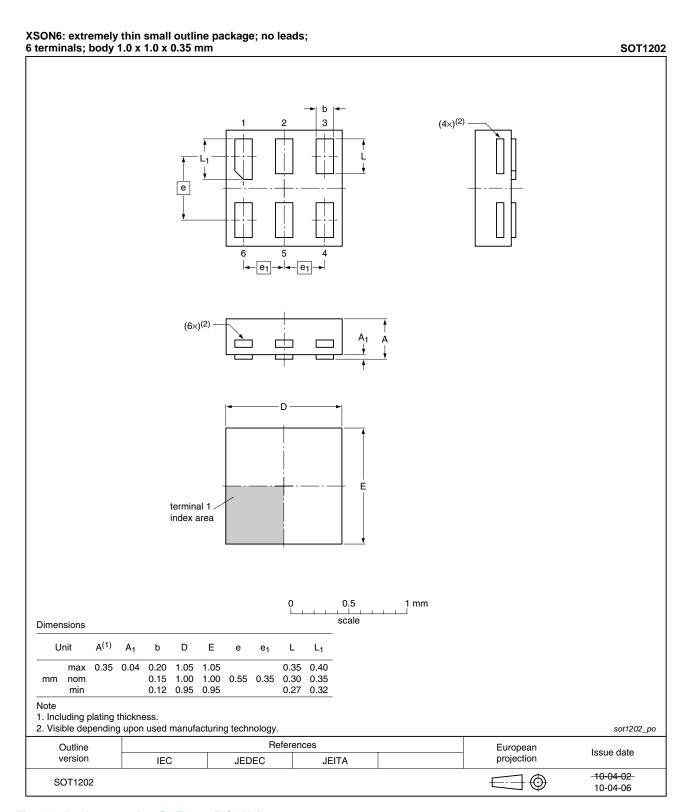


Fig 14. Package outline SOT1202 (XSON6)

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## Low-power D-type flip-flop with reset; positive-edge trigger

## 14. Abbreviations

#### Table 11. Abbreviations

Acronym	Description
CDM	Charged Device Model
DUT	Device Under Test
ESD	ElectroStatic Discharge
НВМ	Human Body Model
MM	Machine Model

# 15. Revision history

#### Table 12. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74AUP1G175 v.3	20100930	Product data sheet	-	74AUP1G175 v.2
Modifications:		number 74AUP1G175GN number 74AUP1G175GS	•	• /
74AUP1G175 v.2	20080228	Product data sheet	-	74AUP1G175 v.1
74AUP1G175 v.1	20061115	Product data sheet	-	-

## 16. Legal information

#### 16.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <a href="http://www.nxp.com">http://www.nxp.com</a>.

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#### Low-power D-type flip-flop with reset; positive-edge trigger

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## Low-power D-type flip-flop with reset; positive-edge trigger

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